

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10553982	OKAYAMA ET AL.
	Examiner	Art Unit
	KRISTIN BIANCHI	1626

SEARCHED

Class	Subclass	Date	Examiner
514	210.2	10/08/08	KB
514	374	10/08/08	KB
514	217.08	10/08/08	KB
514	326	10/08/08	KB
514	383	10/08/08	KB
514	397	10/08/08	KB
540	602	10/08/08	KB
546	210	10/08/08	KB
548	311.1	10/08/08	KB
548	364.1	10/08/08	KB
514	236.2	04/20/09	KB
514	253.09	04/20/09	KB
514	318	04/20/09	KB
514	340	04/20/09	KB
544	124	04/20/09	KB
544	231	04/20/09	KB
544	364	04/20/09	KB
546	193	04/20/09	KB
546	272.4	04/20/09	KB

SEARCH NOTES

Search Notes	Date	Examiner
inventor name search (EAST)	10/08/08	KB
STN structure search	10/07/08	KB
IDS/prior art (eDAN and EAST)	10/08/08	KB
updated classification search (EAST)	04/20/09	KB
interference search (EAST)	04/20/09	KB
updated STN structure search	03/30/09	KB
IDS/prior art filed on 01/16/2009 (EAST and eDAN)	04/20/09	KB
patentability conference	04/02/09	KB

INTERFERENCE SEARCH

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514	236.2	04/20/09	KB
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